


<b>Search Notes</b>  	<b>Application/Control No.</b>  10596213	<b>Applicant(s)/Patent Under Reexamination</b>  SHIN ET AL.
	<b>Examiner</b>  HUYEN D LE	<b>Art Unit</b>  2615

SEARCHED			
Class	Subclass	Date	Examiner
381	190, 191, 398, 399, 400, 401, 403, 404, 408, 431, 433, 417, 418, 176	4/24/08	HL
181	171, 172	4/24/08	HL
381	407, 423	10/22/08	HL

SEARCH NOTES		
Search Notes	Date	Examiner
None	10/22/08	HL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
See East Search History		10/22/08	HL

	/HUYEN D LE/ Primary Examiner.Art Unit 2614
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